



YOUSHANG SEMICONDUCTOR

设计研发新型功率器件

各类小信号开关

中低压及高压大电流等场效应管

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Product Summary

$V_{(BR)DSS}$	$R_{DS(on) \max}$	$I_D \max$ $T_A = +25^\circ\text{C}$ (Note 6)
-30V	45m Ω @ $V_{GS} = -10\text{V}$	-7.5A
	70m Ω @ $V_{GS} = -4.5\text{V}$	-5.9A

Features and Benefits

- Low On-Resistance
- Fast Switching Speed
- Low Threshold
- Low Gate Drive

Description and Applications

This MOSFET is designed to minimize the on-state resistance and yet maintain superior switching performance, making it ideal for high-efficiency power management applications.

- Motor Control
- DC-DC Converters
- Power Management Functions
- Relay and Solenoid Driving

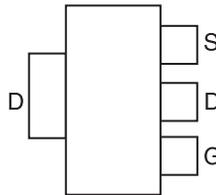
Mechanical Data

- Case: SOT223
- Case Material: Molded Plastic, UL Flammability Classification Rating 94V-0
- Moisture Sensitivity: Level 1 per J-STD-020
- Terminals: Finish - Matte Tin Annealed over Copper Leadframe. Solderable per MIL-STD-202, Method 208 (e3)
- Weight: 0.112 grams (Approximate)

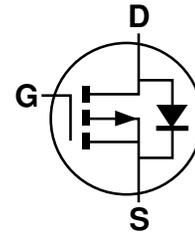
SOT223



Top View



Pin Out - Top View



Equivalent Circuit

Maximum Ratings (@ $T_A = +25^\circ\text{C}$, unless otherwise specified.)

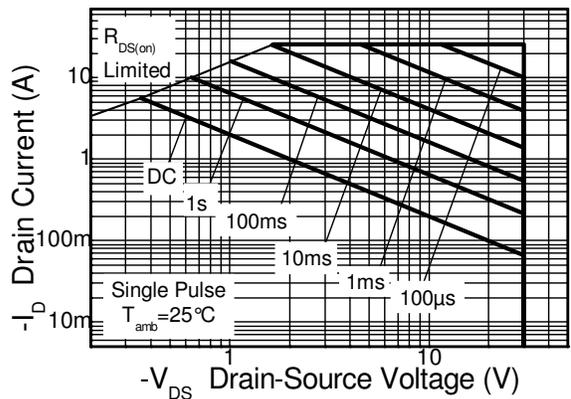
Characteristic		Symbol	Value	Unit	
Drain-Source Voltage		V_{DSS}	-30	V	
Gate-Source Voltage		V_{GS}	± 20	V	
Continuous Drain Current	$V_{GS} = 10\text{V}$	(Note 6)	-7.5	A	
		$T_A = +70^\circ\text{C}$ (Note 6)	-6.0		
		(Note 5)	-5.4		
Pulsed Drain Current	$V_{GS} = 10\text{V}$	(Note 7)	I_{DM}	-24.9	A
Continuous Source Current (Body diode)		(Note 6)	I_S	-3.2	A
Pulsed Source Current (Body diode)		(Note 7)	I_{SM}	-24.9	A

Thermal Characteristics (@ $T_A = +25^\circ\text{C}$, unless otherwise specified.)

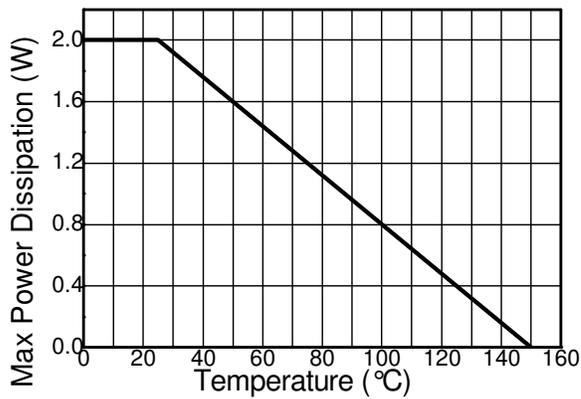
Characteristic		Symbol	Value	Unit
Power Dissipation	(Note 5)	P_D	2.0	W
	Linear Derating Factor		16	
	(Note 6)		3.9	mW/ $^\circ\text{C}$
			31	
Thermal Resistance, Junction to Ambient	(Note 5)	$R_{\theta JA}$	62.5	$^\circ\text{C}/\text{W}$
	(Note 6)		32.2	
Thermal Resistance, Junction to Lead	(Note 8)	$R_{\theta JL}$	8.51	
Operating and Storage Temperature Range		T_J, T_{STG}	-55 to 150	$^\circ\text{C}$

- Notes:
- For a device surface mounted on 25mm x 25mm x 1.6mm FR4 PCB with high coverage of single sided 1oz copper, in still air conditions; the device is measured when operating in a steady-state condition.
 - Same as Note (5), except the device is measured at $t \leq 10$ sec.
 - Same as Note (5), except the device is pulsed with $D = 0.02$ and pulse width 300 μs . The pulse current is limited by the maximum junction temperature.
 - Thermal resistance from junction to solder-point (at the end of the drain lead).

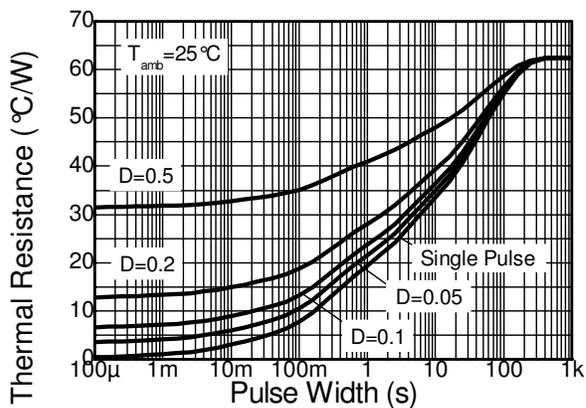
Thermal Characteristics



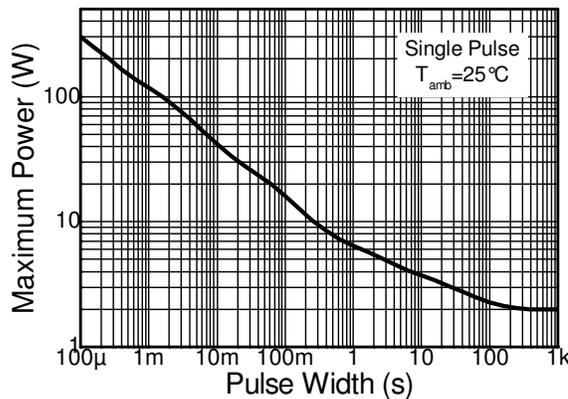
Safe Operating Area



Derating Curve



Transient Thermal Impedance



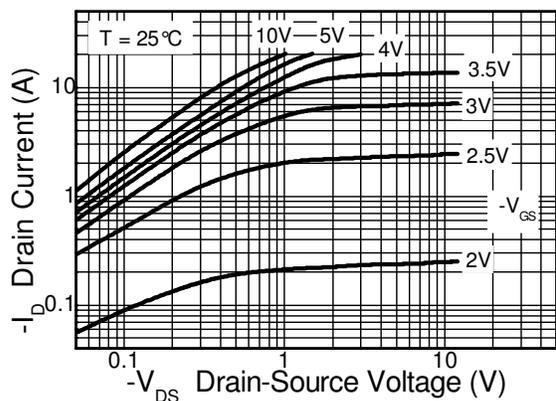
Pulse Power Dissipation

Electrical Characteristics (@ $T_A = +25^\circ\text{C}$, unless otherwise specified.)

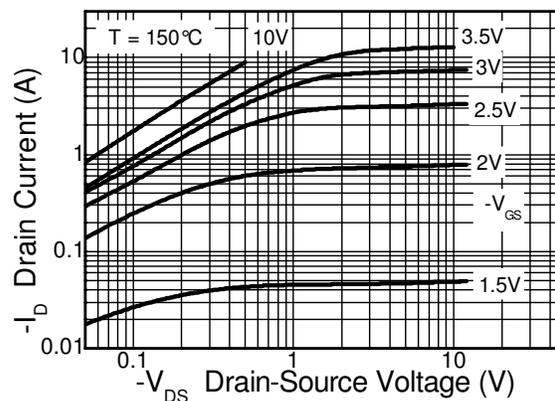
Characteristic	Symbol	Min	Typ	Max	Unit	Test Condition
OFF CHARACTERISTICS						
Drain-Source Breakdown Voltage	BV_{DSS}	-30	—	—	V	$I_D = -250\mu\text{A}$, $V_{GS} = 0\text{V}$
Zero Gate Voltage Drain Current	I_{DSS}	—	—	-1	μA	$V_{DS} = -30\text{V}$, $V_{GS} = 0\text{V}$
Gate-Source Leakage	I_{GSS}	—	—	± 100	nA	$V_{GS} = \pm 20\text{V}$, $V_{DS} = 0\text{V}$
ON CHARACTERISTICS						
Gate Threshold Voltage	$V_{GS(th)}$	-1.0	—	—	V	$I_D = -250\mu\text{A}$, $V_{DS} = V_{GS}$
Static Drain-Source On-Resistance (Note 9)	$R_{DS(on)}$	—	—	45	m Ω	$V_{GS} = -10\text{V}$, $I_D = -4.2\text{A}$
				70		$V_{GS} = -4.5\text{V}$, $I_D = -3.4\text{A}$
Forward Transconductance (Notes 9 & 10)	g_{fs}	—	9.2	—	S	$V_{DS} = -15\text{V}$, $I_D = -4.2\text{A}$
Diode Forward Voltage (Note 9)	V_{SD}	—	-0.85	-0.95	V	$I_S = -3.6\text{A}$, $V_{GS} = 0\text{V}$, $T_J = +25^\circ\text{C}$
Reverse Recovery Time (Note 10)	t_{rr}	—	21.7	—	ns	$I_F = -2\text{A}$, $di/dt = 100\text{A}/\mu\text{s}$, $T_J = +25^\circ\text{C}$
Reverse Recovery Charge (Note 10)	Q_{rr}	—	16.1	—	nC	$T_J = +25^\circ\text{C}$
DYNAMIC CHARACTERISTICS (Note 10)						
Input Capacitance	C_{iss}	—	1,022	—	pF	$V_{DS} = -15\text{V}$, $V_{GS} = 0\text{V}$ $f = 1\text{MHz}$
Output Capacitance	C_{oss}	—	267	—	pF	
Reverse Transfer Capacitance	C_{rss}	—	229	—	pF	
Total Gate Charge (Note 11)	Q_g	—	17.2	—	nC	$V_{GS} = -5\text{V}$
Total Gate Charge (Note 11)	Q_g	—	29.6	—	nC	$V_{GS} = -10\text{V}$ $V_{DS} = -15\text{V}$ $I_D = -4.2\text{A}$
Gate-Source Charge (Note 11)	Q_{gs}	—	2.8	—	nC	
Gate-Drain Charge (Note 11)	Q_{gd}	—	8.6	—	nC	
Turn-On Delay Time (Note 11)	$t_{D(on)}$	—	3.8	—	ns	$V_{DD} = -15\text{V}$, $V_{GS} = -10\text{V}$ $I_D = -1\text{A}$, $R_G \cong 6.0\Omega$
Turn-On Rise Time (Note 11)	t_r	—	6.5	—	ns	
Turn-Off Delay Time (Note 11)	$t_{D(off)}$	—	37.1	—	ns	
Turn-Off Fall Time (Note 11)	t_f	—	21.4	—	ns	

- Notes:
9. Measured under pulsed conditions. Pulse width $\leq 300\mu\text{s}$; duty cycle $\leq 2\%$.
 10. For design aid only, not subject to production testing.
 11. Switching characteristics are independent of operating junction temperatures.

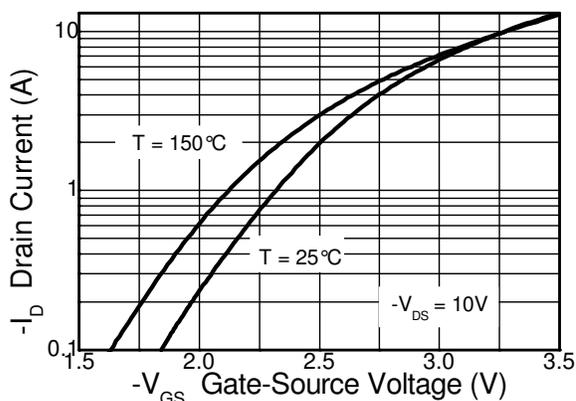
Typical Characteristics



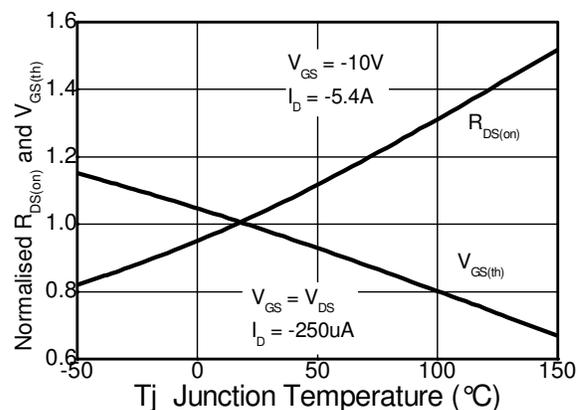
Output Characteristics



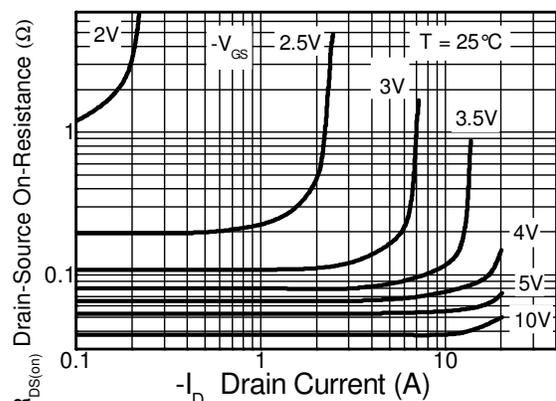
Output Characteristics



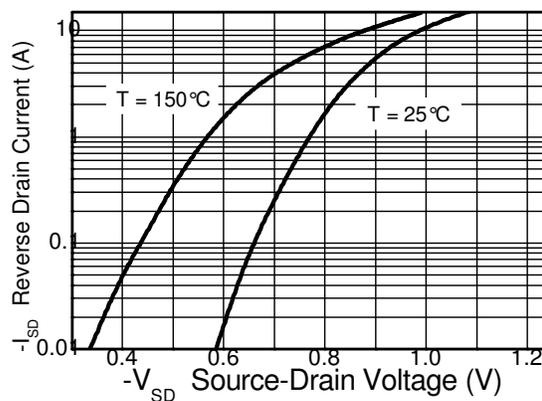
Typical Transfer Characteristics



Normalised Curves v Temperature

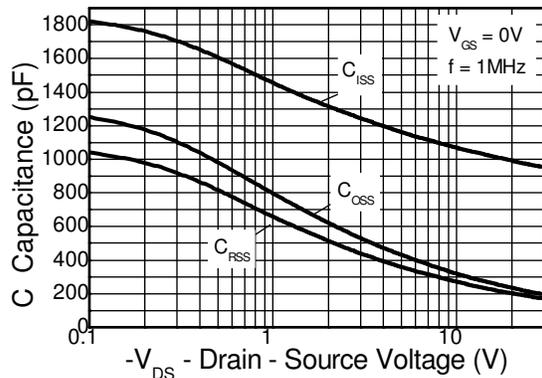


On-Resistance v Drain Current

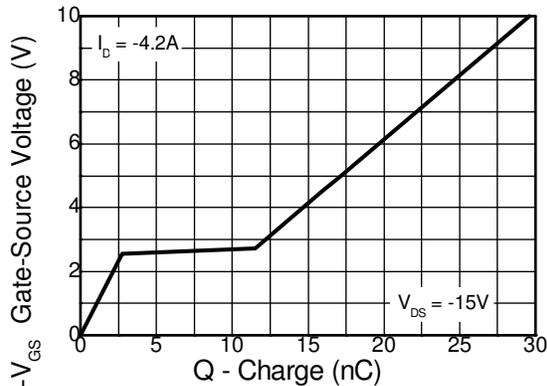


Source-Drain Diode Forward Voltage

Typical Characteristics (continued)

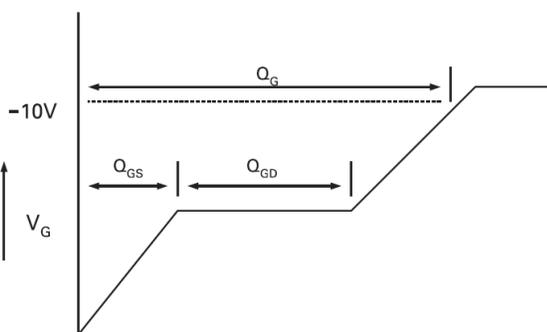


Capacitance v Drain-Source Voltage

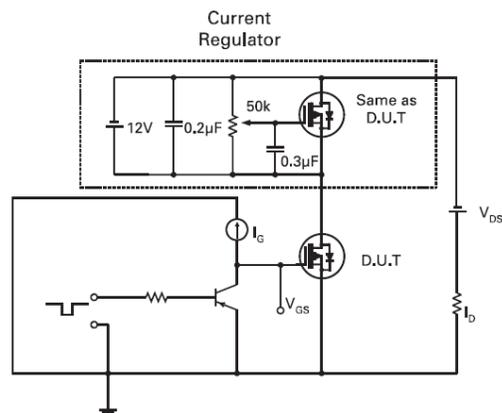


Gate-Source Voltage v Gate Charge

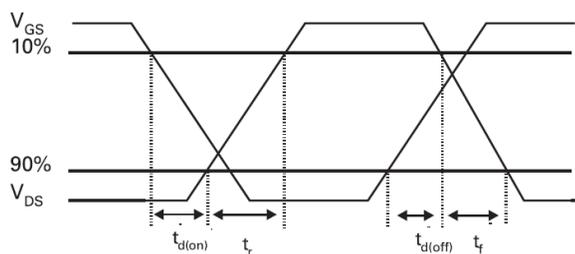
Test Circuits



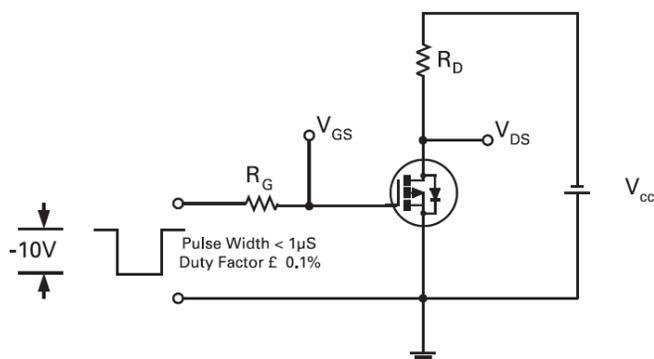
Basic Gate Charge Waveform



Gate Charge Test Circuit

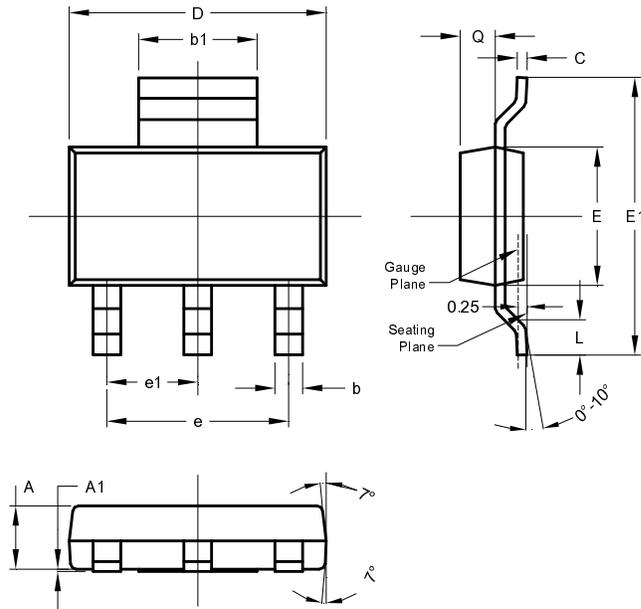


Switching Time Waveforms



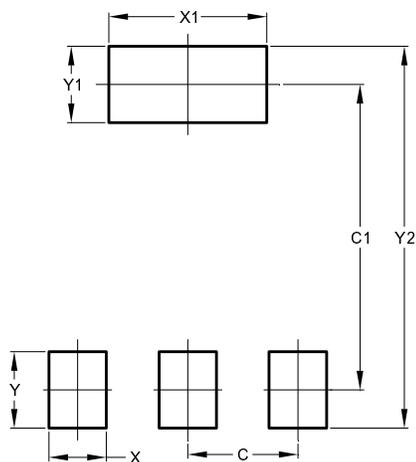
Switching Time Test Circuit

Package Outline Dimensions



SOT223			
Dim	Min	Max	Typ
A	1.55	1.65	1.60
A1	0.010	0.15	0.05
b	0.60	0.80	0.70
b1	2.90	3.10	3.00
C	0.20	0.30	0.25
D	6.45	6.55	6.50
E	3.45	3.55	3.50
E1	6.90	7.10	7.00
e	-	-	4.60
e1	-	-	2.30
L	0.85	1.05	0.95
Q	0.84	0.94	0.89
All Dimensions in mm			

Suggested Pad Layout



Dimensions	Value (in mm)
C	2.30
C1	6.40
X	1.20
X1	3.30
Y	1.60
Y1	1.60
Y2	8.00